## Lecture contents

- P-n junction
  - Electrostatics

1

## **Junctions: general approaches, conventions**

=>

• metal-semiconductor contact

- Formation of potential barriers

• heterojunctions

p-n homojunctions

- Different from bulk material

#### Formalism includes the following phenomena:

- Electrostatics (Gauss law)  $\nabla \cdot \mathcal{E} = \frac{\rho}{\varepsilon_0 \varepsilon} \xrightarrow{replace} \varepsilon$   $\varepsilon_0 \varepsilon \xrightarrow{replace} \varepsilon$ Poisson equation  $-\nabla^2 \phi = \nabla \cdot \mathcal{E} = \frac{\rho}{\varepsilon} SI$ • Statistics (Boltzman for analytical description)  $n = n_i \exp\left(\frac{E_r - E_i}{kT}\right) = N_c \exp\left(\frac{E_r - E_c}{kT}\right)$   $-\nabla^2 \phi = \nabla \cdot \mathcal{E} = \frac{4\pi\rho}{\varepsilon} CGS$ • Continuity equations:  $\frac{\partial n}{\partial t} = G_n - R_n + \frac{1}{q} \nabla \cdot J_n$   $\frac{\partial p}{\partial t} = G_p - R_p - \frac{1}{q} \nabla \cdot J_p$ • Current equations - Drift and diffusion currents  $J_n = nq\mu_n \mathcal{E} + qD_n \nabla n$   $J_p = nq\mu_p \mathcal{E} - qD_p \nabla p$ 
  - Einstein relation (in non-degenerate semiconductor)

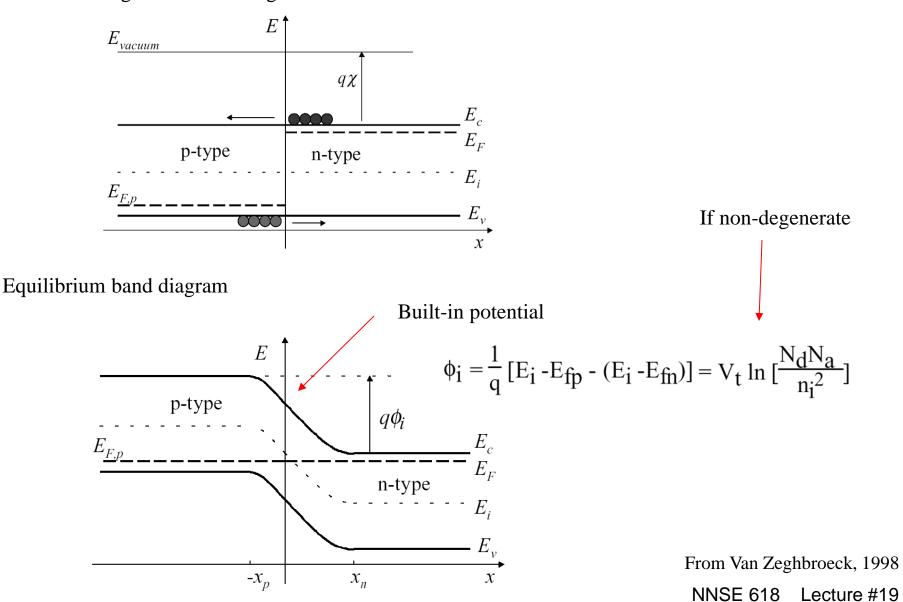
- NNSE 618 Lecture #19
- $D = \frac{k_B T}{q} \mu \longrightarrow J_n = \mu_n \left( nq \mathcal{E} + k_B T \nabla n \right)$

- Thermionic current
- Tunneling current

2

# **Formation of p-n junction**

Flat band diagram before charge redistribution



### **Electrostatics: Full depletion approximation**

Full depletion approximation : impurities are completely ionized within the depletion width

Neutrality requires:

$$N_a x_p = N_d x_n$$

Integrating Poisson equation with boundary conditions (zero field far from the junction):

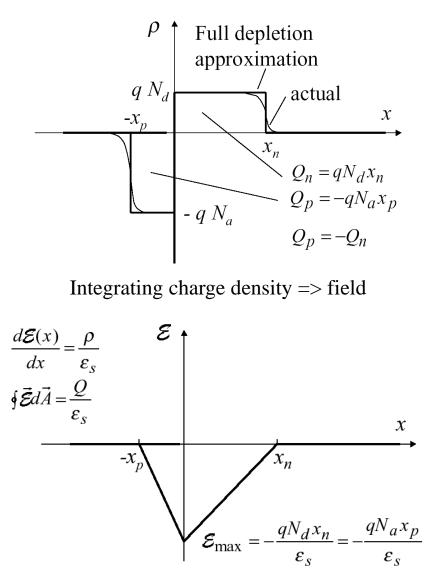
$$-\frac{d^2\phi}{dx^2} = \frac{d\mathcal{E}}{dx} = \frac{\rho}{\varepsilon}$$

for x > 0  $\frac{d\mathcal{E}}{dx} = \frac{q}{\varepsilon} N_d$   $\mathcal{E} = \frac{qN_d}{\varepsilon} (x - x_n)$ 

for x < 0  $\frac{d\mathcal{E}}{dx} = -\frac{q}{\varepsilon}N_a$   $\mathcal{E} = -\frac{qN_a}{\varepsilon}(x+x_p)$ 

From Van Zeghbroeck, 1998

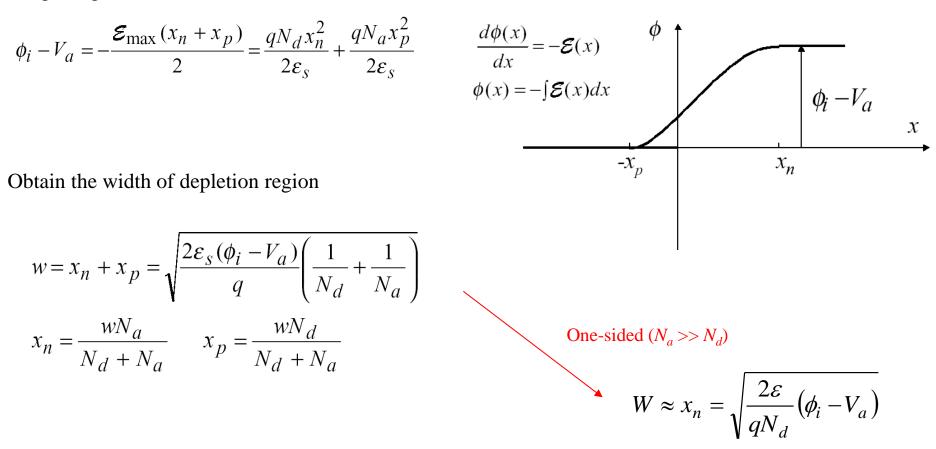
Space charge density in p-n junction



NNSE 618 Lecture #19

### **Electrostatics: Full depletion approximation**

Integrating the field:



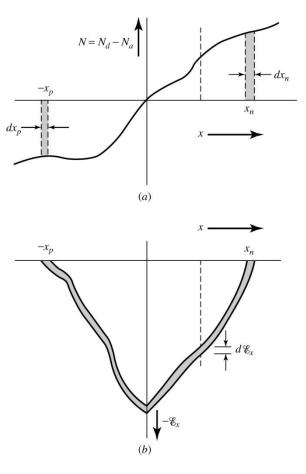
Integrate field => potential (built-in + applied)

#### **Electrostatics: Junction Capacitance**

Capacitance per unit area [F/cm<sup>2</sup>]

$$C = \left| \frac{dQ_n}{dV_a} \right| = \left| \frac{dQ_p}{dV_a} \right|$$
$$Q_n = qN_d x_n = -Q_p = qN_a x_p$$

$$C = \frac{\varepsilon_s}{\sqrt{\frac{2\varepsilon_s(\phi_i - V_a)}{q} \left(\frac{1}{N_d} + \frac{1}{Na}\right)}} = \frac{\varepsilon_s}{x_n + x_p} = \frac{\varepsilon_s}{w}$$



#### Figure 4.11 (Muller, Kamins 2003)

(a) Dopant concentration in an arbitrarily doped junction, showing modulation of the carrier densities at the edges of the space-charge region by an applied voltage.

(*b*) Electric-field distributions for two slightly different applied voltages.

#### **Electrostatics: Full depletion vs. exact solution**

For exact electrostatic solution Poisson equation should be integrated with free carriers:

$$\frac{d^2\phi(x)}{dx^2} = -\frac{q}{\varepsilon_s}(p-n+N_d^+-N_a^-)$$

As in the case of MS junction, the depletion layer width on each side is increased by the Debye length

$$L_D = \left(\frac{\varepsilon}{qn} \frac{kT}{q}\right)^{1/2}$$

$$W = x_n + x_p = \sqrt{\frac{2\varepsilon}{q} \frac{N_d + N_a}{N_d N_a} (\phi_i - V_a - 2V_t)}$$

Or for one-sided junction:

$$W = \sqrt{\frac{2\varepsilon}{qN_d} \left(\phi_i - V_a - 2V_t\right)} = L_D \sqrt{2\left(\frac{\phi_i}{V_t} - \frac{V_a}{V_t} - 2\right)}$$

Space charge: Full depletion vs. exact solution

